

Notice of References Cited	Application/Control No. 10/776,286		Applicant(s)/Patent Under Reexamination ONOZAWA ET AL.	
	Examiner Leith A. Al-Nazer		Art Unit 2821	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,502,412	03-1996	Choi et al.	327/333
*	B	US-2002/0175883	11-2002	Onozawa et al.	345/67
	C	US-			
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	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 02/095914 A2	11-2002	PCT	Stanley, Gerald R.	H02M
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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